

## **Revision History List**

## 512K x 16 bit -AS6C8016-55TIN - 48-pin TSOP I PACKAGE

Revision	Details	Date
Rev. 1.0	Initial Issue	November12.2015

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#### **FEATURES**

Fast access time : 55nsLow power consumption:

Operating current : 30/20mA (TYP.) Standby current : 1.5μA (TYP.) SL-version

■ Single 2.7V ~ 3.6V power supply

■ All inputs and outputs TTL compatible

■ Fully static operation

■ Tri-state output

■ Data byte control : LB# (DQ0 ~ DQ7)

UB# (DQ8 ~ DQ15)

■ Data retention voltage : 1.2V(MIN.)

■ Package: 48-pin 12mm x 20mm TSOP-I

■ Green & ROHS Compliant

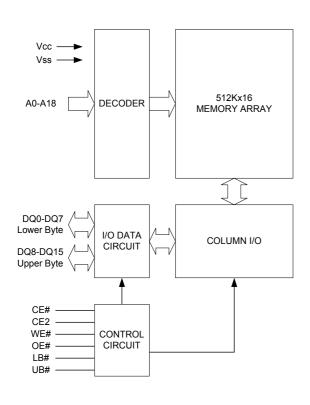
#### **GENERAL DESCRIPTION**

The AS6C8016-55TIN is a 8,388,608-bit low power CMOS static random access memory organized as 524,288 words by 16 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

The AS6C8016-55TIN is well designed for low power application, and particularly well suited for battery back-up nonvolatile memory application.

The AS6C8016-55TIN operates from a single power supply of 2.7V ~ 3.6V and all inputs and outputs are fully TTL compatible

#### **FUNCTIONAL BLOCK DIAGRAM**



#### PIN DESCRIPTION

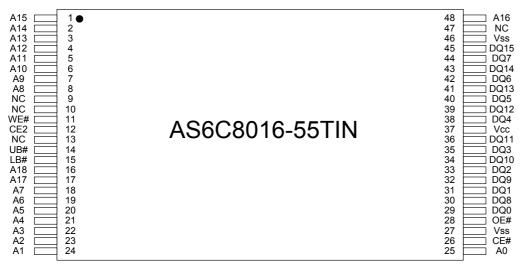
SYMBOL	DESCRIPTION
A0 - A18	Address Inputs
DQ0 – DQ15	Data Inputs/Outputs
CE#, CE2	Chip Enable Input
WE#	Write Enable Input
OE#	Output Enable Input
LB#	Lower Byte Control
UB#	Upper Byte Control
Vcc	Power Supply
Vss	Ground

### **PRODUCT FAMILY**

Product	Operating	Vcc Range	Spood	Power Di	Dissipation		
Family	Temperature	vcc Range	Speed	Standby(IsB1,TYP.)	Operating(Icc,TYP.)		
AS6C8016-55TIN	-40°C ~ 85°C	2.7 ~ 3.6V	55ns	1.5µA(SL)	30/20mA		



### **PIN CONFIGURATION**



TSOP-I

#### **ABSOLUTE MAXIMUM RATINGS\***

PARAMETER	SYMBOL	RATING	UNIT
Voltage on Vcc relative to Vss	VT1	-0.5 to 4.6	V
Voltage on any other pin relative to Vss	VT2	-0.5 to Vcc+0.5	V
On a ratio a Tampa a rationa	т.	0 to 70(C grade)	°C
Operating Temperature	TA	-40 to 85(I grade)	C
Storage Temperature	Тѕтс	-65 to 150	$^{\circ}\mathbb{C}$
Power Dissipation	PD	1	W
DC Output Current	Іоит	50	mA

\*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

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### **TRUTH TABLE**

MODE	CE#	CE2	OE#	WE#	NE# LB# UB# I/O OPERATION SU		SUPPLY CURRENT		
WIODE	CE#	CEZ	OE#	VVE#	LD#	06#	DQ0-DQ7	DQ8-DQ15	SUPPLI CURRENT
	Н	Х	Х	Х	Х	Х	High – Z	High – Z	
Standby	Х	L	Х	Х	Χ	Х	High – Z	High – Z	ISB,ISB1
	Х	Χ	Х	Х	Η	Н	High – Z	High – Z	
Output Disable	L	Н	Н	Н	L	X	High – Z	High – Z	lcc,lcc1
Output Disable	L	Н	Н	Н	Χ	L	High – Z	High – Z	100,1001
	L	Н	L	Н	L	Η	$D_OUT$	High – Z	
Read	L	Н	L	Н	Н	L	High – Z	D <sub>OUT</sub>	Icc,Icc1
	L	Н	L	Н	L	L	$D_OUT$	D <sub>OUT</sub>	
	L	Н	Х	L	L	Η	$D_IN$	High – Z	
Write	L	Н	Х	L	Н	L	High – Z	$D_IN$	Icc,Icc1
	L	Н	Χ	L	L	L	$D_IN$	D <sub>IN</sub>	

Note: H = V<sub>IH</sub>, L = V<sub>IL</sub>, X = Don't care.

### DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	ON		MIN.	TYP. *4	MAX.	UNIT
Supply Voltage	Vcc				2.7	3.0	3.6	V
Input High Voltage	V <sub>IH</sub> *1				2.2	ı	V <sub>CC</sub> +0.3	V
Input Low Voltage	VIL <sup>*2</sup>				- 0.2	-	0.6	V
Input Leakage Current	ILI	Vcc Vin Vss			- 1	-	1	μΑ
Output Leakage Current	ILO	Vcc Vouт Vss, Output Disabled	Vcc Vout Vss,			1	1	μΑ
Output High Voltage	Vон	Iон = -1mA			2.2	2.7	-	V
Output Low Voltage	Vol	I <sub>OL</sub> = 2mA			ı	ı	0.4	V
•	lcc	Cycle time = Min. CE# = V <sub>IL</sub> and CE2 = \	/ін	- 55	-	30	40	mA
Average Operating		I <sub>I/O</sub> = 0mA Other pins at V <sub>I</sub> L or V <sub>I</sub> H	l	- 70	-	20	30	mA
Power supply Current	Icc1	Cycle time = $1\mu$ s CE# $\leq$ 0.2V and CE2 $\geq$ Vcc-0.2V I <sub>I/O</sub> = 0mA Other pins at 0.2V or Vcc-0.2V			-	4	8	mA
	I <sub>SB</sub>	CE# = VIH or CE2 = VIL Other pins at VIL or VIH	CE# = V <sub>IH</sub> or CE2 = V <sub>IL</sub>			0.15	1	mA
Standby Power Supply Current	I <sub>SB1</sub>	CE# Vcc-0.2V or CE2≦0.2V Other pins at 0.2V or Vcc-0.2V	*SLI*5	25℃ 40℃		1.5 1.5	5 5 20	μΑ μΑ μΑ

### Notes:

- 1.  $V_{IH}(max)$  =  $V_{CC}$  + 3.0V for pulse width less than 10ns. 2.  $V_{IL}(min)$  =  $V_{SS}$  3.0V for pulse width less than 10ns.
- 3. Over/Undershoot specifications are characterized, not 100% tested.
- 4. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at Vcc = Vcc(TYP.) and TA =  $25^{\circ}$ C
- 5. This parameter is measured at Vcc = 3.0V



### **CAPACITANCE** (TA = 25 , f = 1.0MHz)

PARAMETER	SYMBOL	MIN.	MAX	UNIT
Input Capacitance	Cin	-	6	pF
Input/Output Capacitance	CI/O	-	8	pF

Note: These parameters are guaranteed by device characterization, but not production tested.

### **AC TEST CONDITIONS**

Input Pulse Levels	0.2V to Vcc - 0.2V
Input Rise and Fall Times	3ns
Input and Output Timing Reference Levels	1.5V
Output Load	$C_L = 30pF + 1TTL$ , $I_{OH}/I_{OL} = -1mA/2mA$

### **AC ELECTRICAL CHARACTERISTICS**

#### (1) READ CYCLE

PARAMETER	SYM.	AS6C801	6-55TIN	UNIT	
		MIN.	MAX.		
Read Cycle Time	trc	55	ı	ns	
Address Access Time	taa	-	55	ns	
Chip Enable Access Time	<b>t</b> ACE	-	55	ns	
Output Enable Access Time	toe	-	30	ns	
Chip Enable to Output in Low-Z	tcLz*	10	-	ns	
Output Enable to Output in Low-Z	tolz*	5	-	ns	
Chip Disable to Output in High-Z	tcHz*	-	20	ns	
Output Disable to Output in High-Z	tonz*	-	20	ns	
Output Hold from Address Change	tон	10	-	ns	
LB#, UB# Access Time	tва	-	55	ns	
LB#, UB# to High-Z Output	t <sub>BHZ</sub> *	-	25	ns	
LB#, UB# to Low-Z Output	t <sub>BLZ</sub> *	10	-	ns	

### (2) WRITE CYCLE

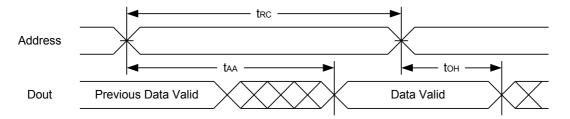
PARAMETER	SYM.	AS6C801	UNIT	
		MIN.	MAX.	
Write Cycle Time	twc	55	-	ns
Address Valid to End of Write	taw	50	-	ns
Chip Enable to End of Write	tcw	50	-	ns
Address Set-up Time	tas	0	-	ns
Write Pulse Width	twp	45	-	ns
Write Recovery Time	twr	0	-	ns
Data to Write Time Overlap	tow	25	-	ns
Data Hold from End of Write Time	tон	0	_	ns
Output Active from End of Write	tow*	5	_	ns
Write to Output in High-Z	twnz*	-	20	ns
LB#, UB# Valid to End of Write	tew	45	-	ns

<sup>\*</sup>These parameters are guaranteed by device characterization, but not production tested.

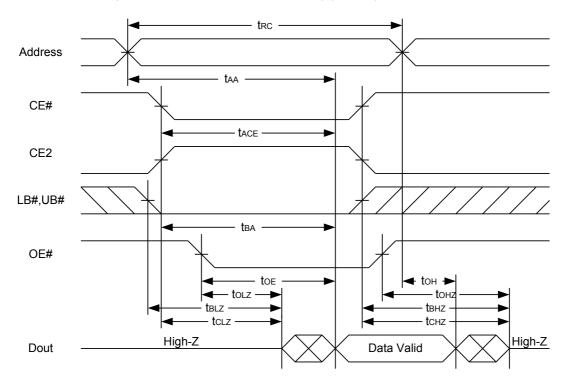


### **TIMING WAVEFORMS**

#### READ CYCLE 1 (Address Controlled) (1,2)



### READ CYCLE 2 (CE# and CE2 and OE# Controlled) (1,3,4,5)

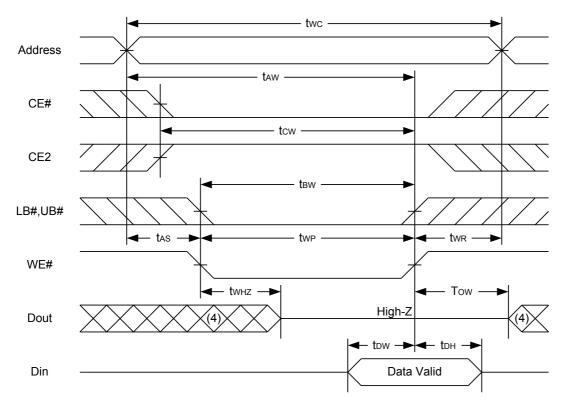


#### Notes:

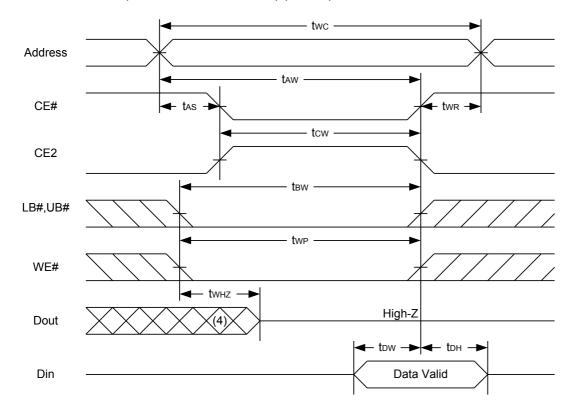
- 1.WE#is high for read cycle.
- 2.Device is continuously selected OE# = low, CE# = low, CE2 = high, LB# or UB# = low.
- 3.Address must be valid prior to or coincident with CE# = low, CE2 = high, LB# or UB# = low transition; otherwise tAA is the limiting parameter.
- 4.tcLz, tbLz, toLz, tcHz, tbHz and toHz are specified with CL = 5pF. Transition is measured ±500mV from steady state.
- 5.At any given temperature and voltage condition,  $t_{CHZ}$  is less than  $t_{CLZ}$ ,  $t_{BHZ}$  is less than  $t_{BLZ}$ ,  $t_{OHZ}$  is less than  $t_{OLZ}$ .



### WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)

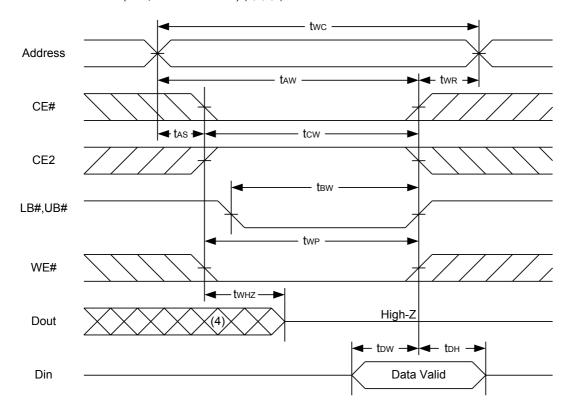


### WRITE CYCLE 2 (CE# and CE2 Controlled) (1,2,5,6)





#### WRITE CYCLE 3 (LB#,UB# Controlled) (1,2,5,6)



#### Notes:

- 1.WE#,CE#, LB#, UB# must be high or CE2 must be low during all address transitions.
- 2.A write occurs during the overlap of a low CE#, high CE2, low WE#, LB# or UB# = low.
- 3.During a WE# controlled write cycle with OE# low, twp must be greater than twHz + tpw to allow the drivers to turn off and data to be placed on the bus.
- 4. During this period, I/O pins are in the output state, and input signals must not be applied.
- 5.If the CE#, LB#, UB# low transition and CE2 high transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
- 6.tow and twHz are specified with  $C_L$  = 5pF. Transition is measured ±500mV from steady state.



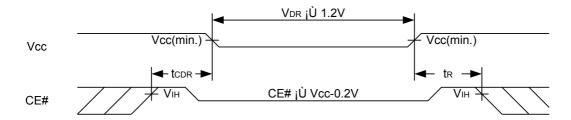
### **DATA RETENTION CHARACTERISTICS**

PARAMETER	SYMBOL	TEST CONDITION			MIN.	TYP.	MAX.	UNIT
Vcc for Data Retention	VDR	CE# $V_{CC}$ - 0.2V or CE2 $\leq$ 0.2V	/		1.2	-	3.6	V
				25℃	-	1	3	μA
Data Retention Current		Other pins at 0.2V or CE2 ≤ 0.2V or Vcc-0.2V	SLI	40℃	-	1	3	μA
					-			
			SLI		-	1	20	μΑ
Chip Disable to Data Retention Time	tcdr	See Data Retention Waveforms (below)			0	-	-	ns
Recovery Time	tr				tRC∗	-	-	ns

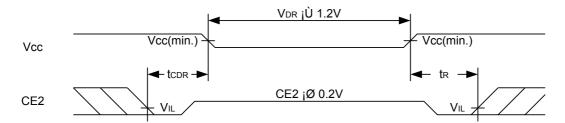
tRC\* = Read Cycle Time

### **DATA RETENTION WAVEFORM**

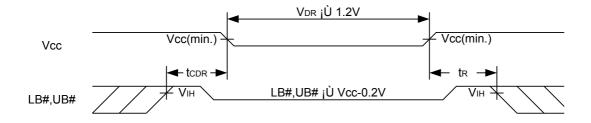
Low Vcc Data Retention Waveform (1) (CE# controlled)



Low Vcc Data Retention Waveform (2) (CE2 controlled)



Low Vcc Data Retention Waveform (3) (LB#, UB# controlled)

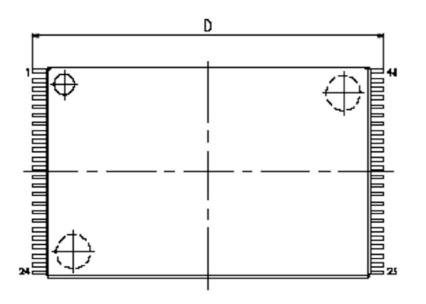


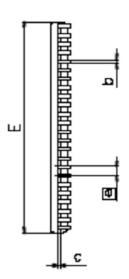
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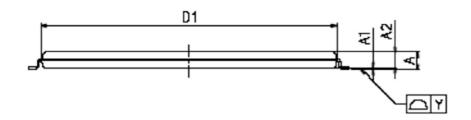


#### PACKAGE OUTLINE DIMENSION

#### 48-pin 12mm x 20mm TSOP-I Package Outline Dimension

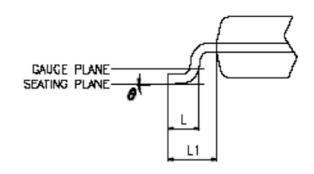






### VARIATIONS (ALL DIMENSIONS SHOWN IN MM)

	SYMBOLS	MIN.	NOM.	MAX
	A	ı	ı	1.20
	A1	0.05	ı	0.15
	A2	0.95	1.00	1.05
	ь	0.17	0.22	0.27
	C	0.10	-	0.21
Δ		19.80	20.00	20.20
Δ	□1	18.30	18.40	18.50
Δ	E	11.90	12.00	12.10
	₽	•	0.50 BASI	C
	┙	0.50	0.60	0.70
Λ	L1	ı	ი.80	-
$\Phi$	Y	_	_	0.10
Δ	θ	Ġ	_	5



#### NOTES:

- 1 JEDEC OUTLINE : MO-142 DO
- 2.PROFILE TOLERANCE ZONES FOR 01 AND E DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE MOLD PROTRUSION ON E IS 0.15 mm PER SIDE AND ON D1 IS 0.25 mm PER SIDE.
- 3.D MENSION ID DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08mm TOTAL IN EXCESS OF THE 15 DIMENSION AT NAXIMUN MATERIAL CONDITION DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT.



#### PART NUMBERING SYSTEM

AS6C	8016	55	Т	_	N
SRAM	8M=512K x 16	Speed=55 ns	T = 48pin TSOP I	I=Industrial (-40°C∼85°C)	Indicates Pb and Halogen Free



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